Notice of References Cited Application/Control No. 10/553,088 Examiner Alicia M. Toscano Applicant(s)/Patent Under Reexamination MIYAMA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name .	Classification
*	Α	US-2006/0255494	11-2006	Ohtomo et al.	264/171.1
	В	US-			
	С	US-			
	D	US-			
	Е	US-			<u> </u>
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-		.1	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name .	Classification
*	N	JP 2003213112 A	07-2003	Japan	OTOMO et al.	
	04	JP 2000052408 A	02-2000	Japan	TAGUCHI et al.	
Α.	P/	WO 2004072158 A1	08-2004	World Intellect	OHTOMO et al.	
	à	JP 2004195685 A	07-2004	Japan	MASUDA, SHIGEHIRO	
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ 4	English translations of JP2003213112A (whole document), JP 2000052408A (whole document), JP 2004195685A (abstract only)_
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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